

Search Notes

Application No.

10/644,167

Examiner

Dao L. Phan

Applicant(s)

YEE ET AL.

Art Unit

3662

SEARCHED

Class	Subclass	Date	Examiner
342	357.06	2/20/4	DP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR